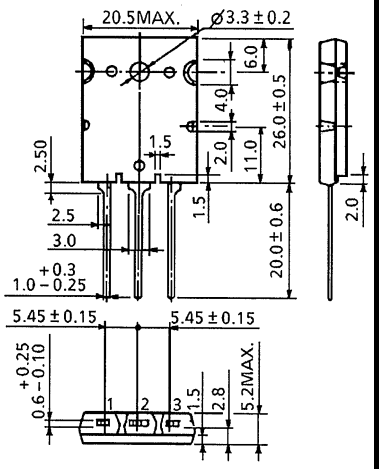
TOSHIBA Insulated Gate Bipolar Transistor Silicon N Channel IGBT

GT60J323

Current Resonance Inverter Switching Application

- Enhancement mode type
- High speed : t_f = 0.16 μs (typ.) (I_C = 60A)
- Low saturation voltage: $V_{CE\ (sat)}$ = 1.9 V (typ.) (I_C = 60A)
- FRD included between emitter and collector
- Fourth generation IGBT
- TO-3P(LH) (Toshiba package name)

Unit: mm



1. GATE
2. COLLECTOR (HEAT SINK)
3. EMITTER

JEDEC	—
JEITA	—
TOSHIBA	2-21F2C

Weight: 9.75 g (typ.)

Absolute Maximum Ratings (Ta = 25°C)

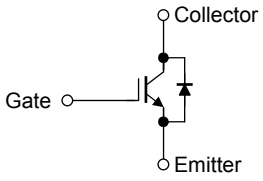
Characteristics		Symbol	Rating	Unit
Collector-emitter voltage		V_{CES}	600	V
Gate-emitter voltage		V_{GES}	±25	V
Continuous collector current	@ Tc = 100°C	I_C	33	A
	@ Tc = 25°C		60	
Pulsed collector current		I_{CP}	120	A
Diode forward current	DC	I_F	30	A
	Pulsed	I_{FP}	120	
Collector power dissipation	@ Tc = 100°C	P_C	68	W
	@ Tc = 25°C		170	
Junction temperature		T_j	150	°C
Storage temperature range		T_{stg}	−55 to 150	°C

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.
Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook (“Handling Precautions”/Derating Concept and Methods) and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

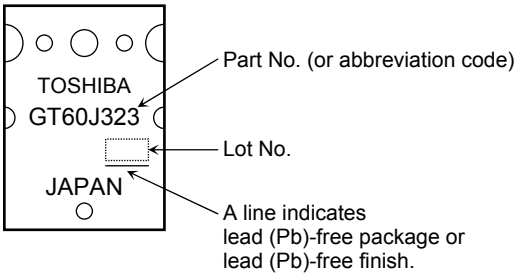
Thermal Characteristics

Characteristics	Symbol	Max	Unit
Thermal resistance (IGBT)	$R_{th\ (j\text{-}c)}$	0.74	°C/W
Thermal resistance (diode)	$R_{th\ (j\text{-}c)}$	1.56	°C/W

Equivalent Circuit



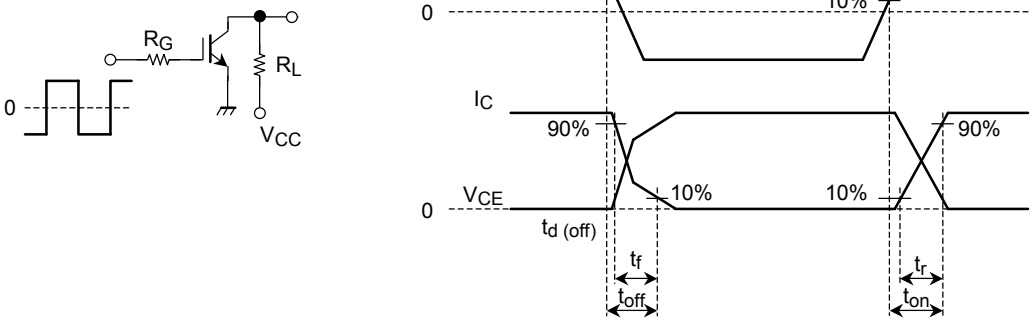
Marking



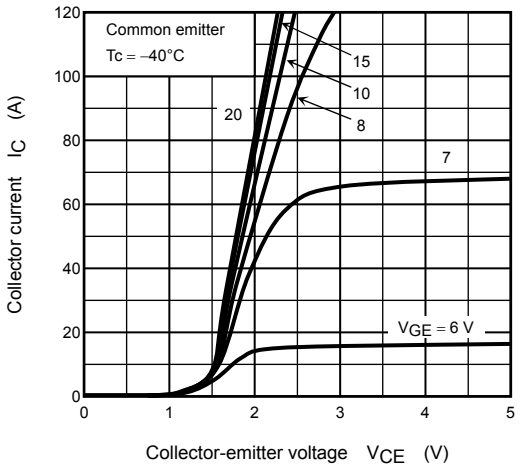
Electrical Characteristics (Ta = 25°C)

Characteristics		Symbol	Test Condition	Min	Typ.	Max	Unit
Gate leakage current		I_{GES}	V_{GE} = ±25 V, V_{CE} = 0	—	—	±500	nA
Collector cut-off current		I_{CES}	V_{CE} = 600 V, V_{GE} = 0	—	—	1.0	mA
Gate-emitter cut-off voltage		$V_{GE\ (OFF)}$	I_C = 60 mA, V_{CE} = 5 V	3.0	—	6.0	V
Collector-emitter saturation voltage		$V_{CE\ (sat)}$	I_C = 60 A, V_{GE} = 15 V	—	1.9	2.5	V
Input capacitance		C_{ies}	V_{CE} = 10 V, V_{GE} = 0, f = 1 MHz	—	4800	—	pF
Switching time	Rise time	t_r	Resistive Load	—	0.17	—	μs
	Turn-on time	t_{on}	V_{CC} = 300 V, I_C = 60 A	—	0.23	—	
	Fall time	t_f	V_{GG} = ±15 V, R_G = 30 Ω	—	0.16	0.26	
	Turn-off time	t_{off}	(Note 1)	—	0.41	—	
Diode forward voltage		V_F	I_F = 30 A, V_{GE} = 0	—	1.4	2.0	V
Reverse recovery time		t_{rr}	I_F = 30 A, di/dt = −100 A/μs	—	0.1	0.2	μs

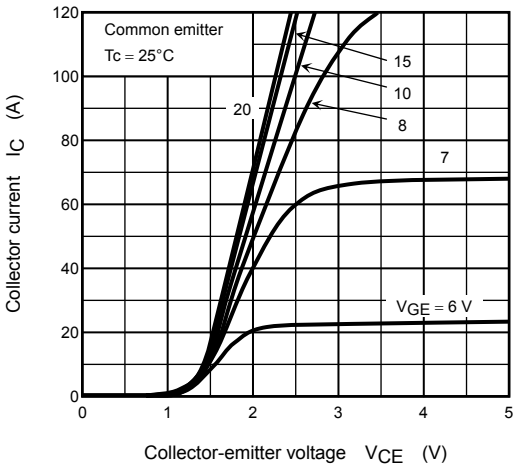
Note 1: Switching time measurement circuit and input/output waveforms



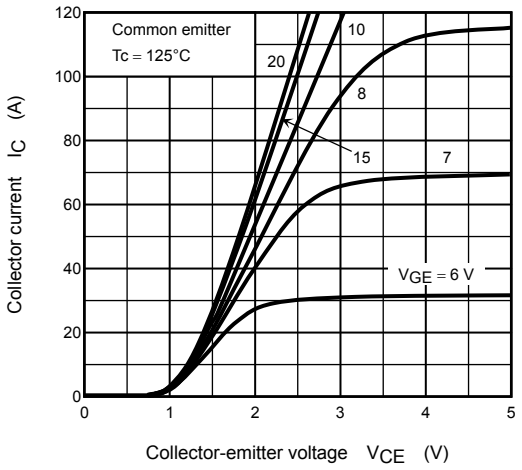
$I_C - V_{CE}$



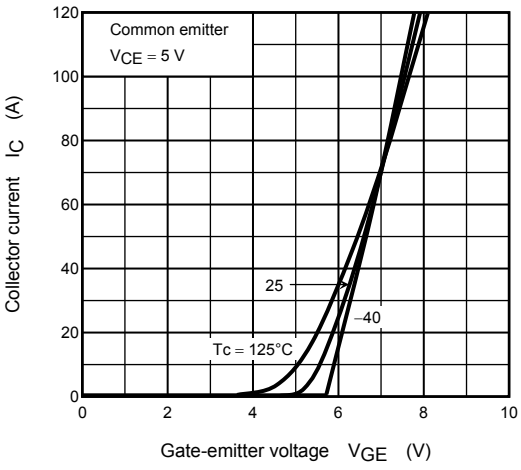
$I_C - V_{CE}$



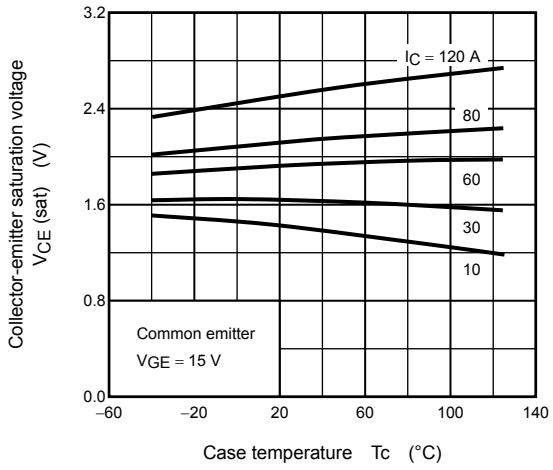
$I_C - V_{CE}$



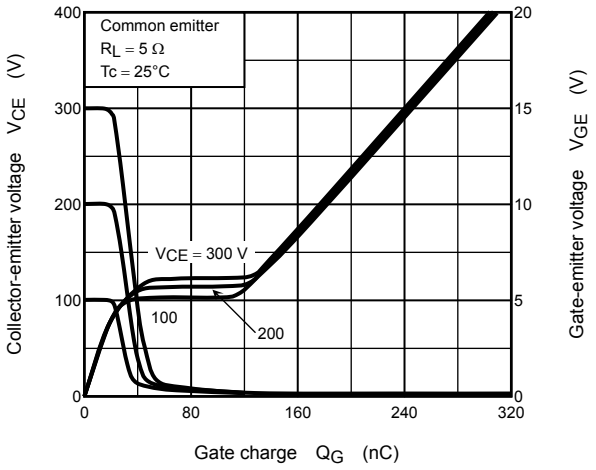
$I_C - V_{GE}$



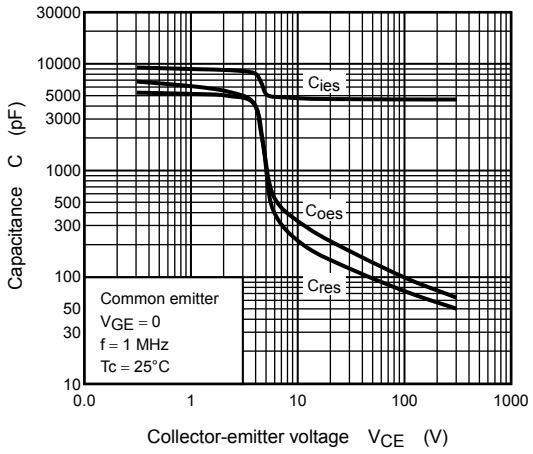
$V_{CE\ (sat)} - Tc$



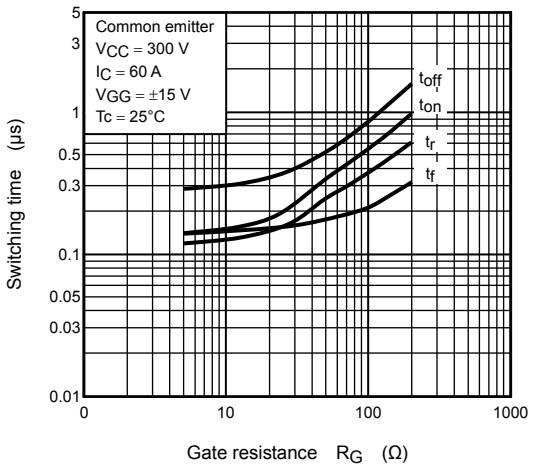
V_{CE}, V_{GE} – Q_G



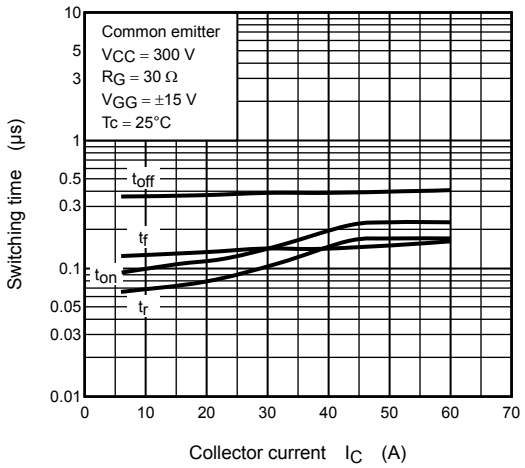
C – V_{CE}



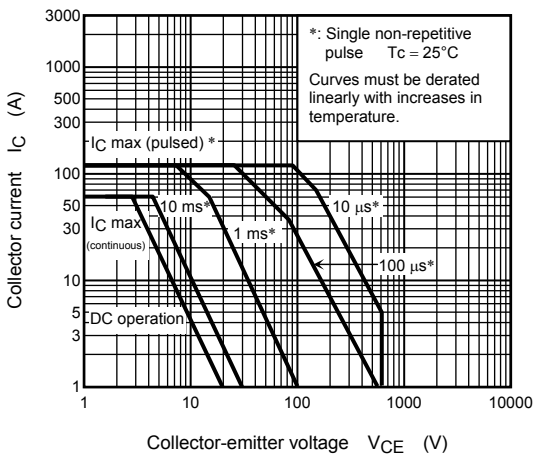
Switching Time – R_G



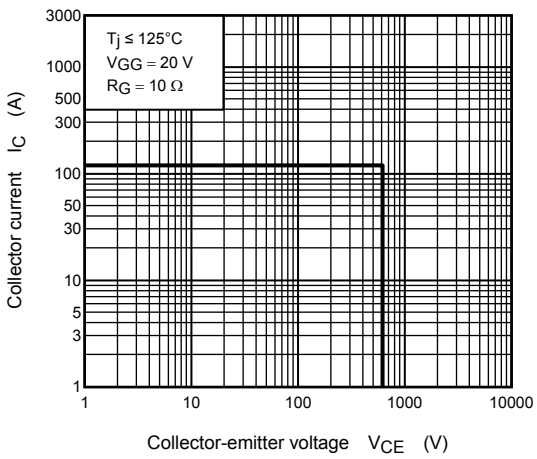
Switching Time – I_C



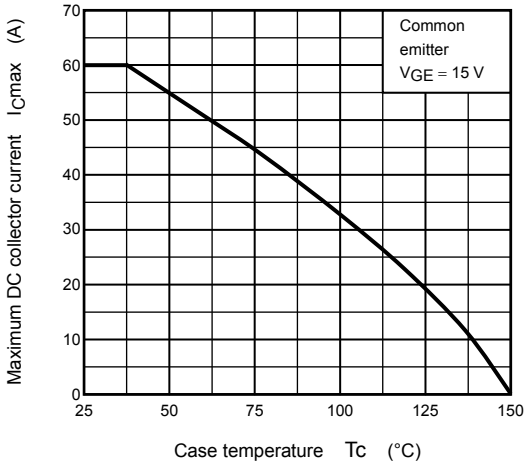
Safe Operating Area



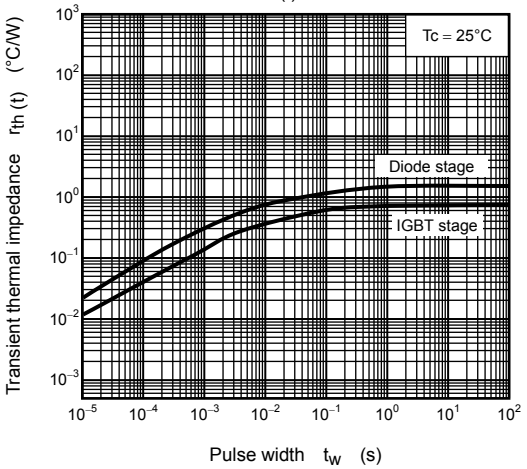
Reverse Bias SOA



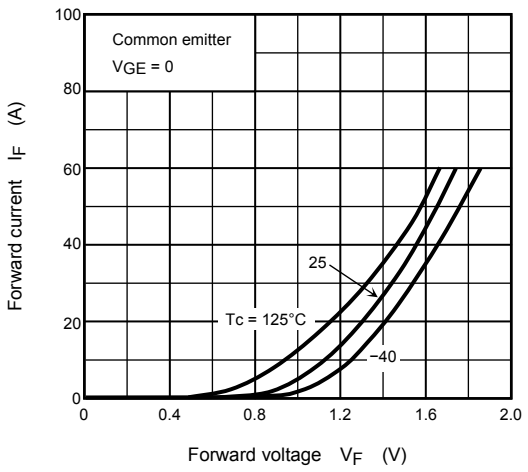
$I_C$max – Tc



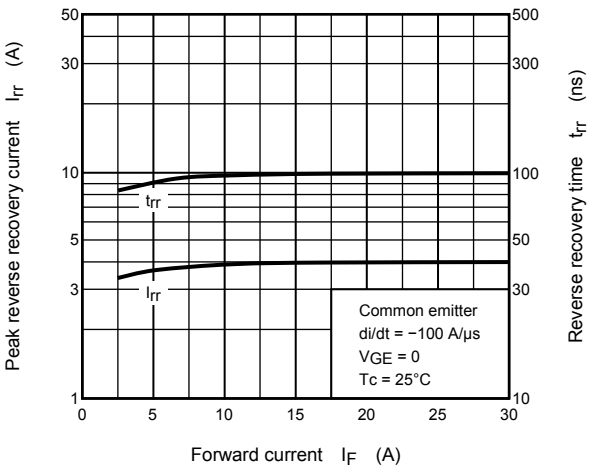
$r_{th\ (t)}$ – t_w



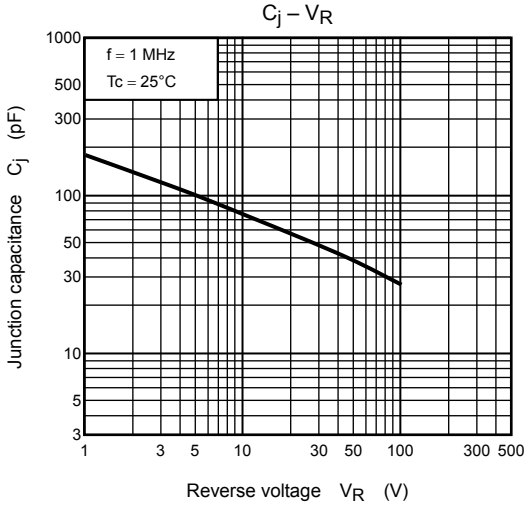
I_F – V_F



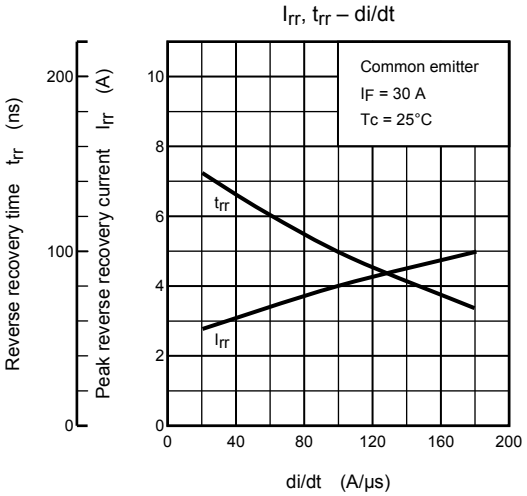
I_{rr}, t_{rr} – I_F



C_j – V_R



I_{rr}, t_{rr} – di/dt



RESTRICTIONS ON PRODUCT USE

20070701-EN

- The information contained herein is subject to change without notice.
- TOSHIBA is continually working to improve the quality and reliability of its products. Nevertheless, semiconductor devices in general can malfunction or fail due to their inherent electrical sensitivity and vulnerability to physical stress. It is the responsibility of the buyer, when utilizing TOSHIBA products, to comply with the standards of safety in making a safe design for the entire system, and to avoid situations in which a malfunction or failure of such TOSHIBA products could cause loss of human life, bodily injury or damage to property.
  In developing your designs, please ensure that TOSHIBA products are used within specified operating ranges as set forth in the most recent TOSHIBA products specifications. Also, please keep in mind the precautions and conditions set forth in the “Handling Guide for Semiconductor Devices,” or “TOSHIBA Semiconductor Reliability Handbook” etc.
- The TOSHIBA products listed in this document are intended for usage in general electronics applications (computer, personal equipment, office equipment, measuring equipment, industrial robotics, domestic appliances, etc.).These TOSHIBA products are neither intended nor warranted for usage in equipment that requires extraordinarily high quality and/or reliability or a malfunction or failure of which may cause loss of human life or bodily injury (“Unintended Usage”). Unintended Usage include atomic energy control instruments, airplane or spaceship instruments, transportation instruments, traffic signal instruments, combustion control instruments, medical instruments, all types of safety devices, etc.. Unintended Usage of TOSHIBA products listed in his document shall be made at the customer’s own risk.
- The products described in this document shall not be used or embedded to any downstream products of which manufacture, use and/or sale are prohibited under any applicable laws and regulations.
- The information contained herein is presented only as a guide for the applications of our products. No responsibility is assumed by TOSHIBA for any infringements of patents or other rights of the third parties which may result from its use. No license is granted by implication or otherwise under any patents or other rights of TOSHIBA or the third parties.
- Please contact your sales representative for product-by-product details in this document regarding RoHS compatibility. Please use these products in this document in compliance with all applicable laws and regulations that regulate the inclusion or use of controlled substances. Toshiba assumes no liability for damage or losses occurring as a result of noncompliance with applicable laws and regulations.